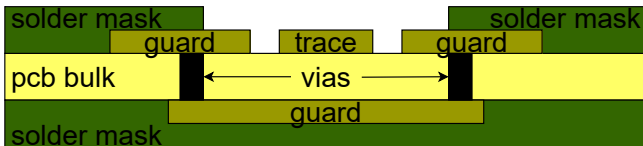


Appendix

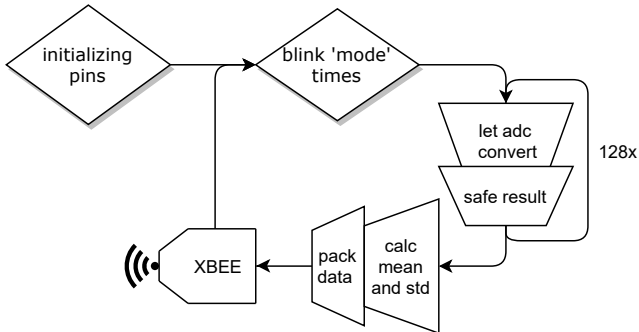
Florian Rössing

June 9, 2020

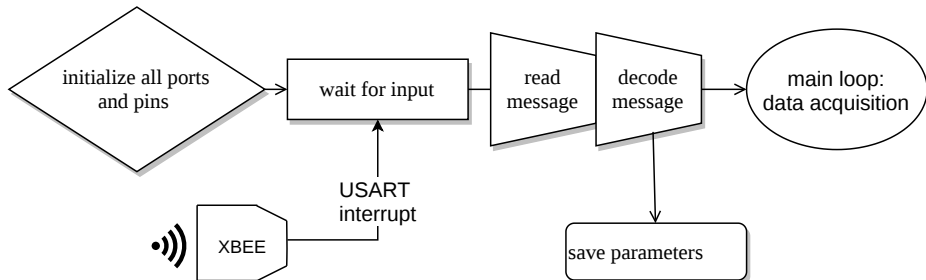
Guarding



Firmware Workflow I



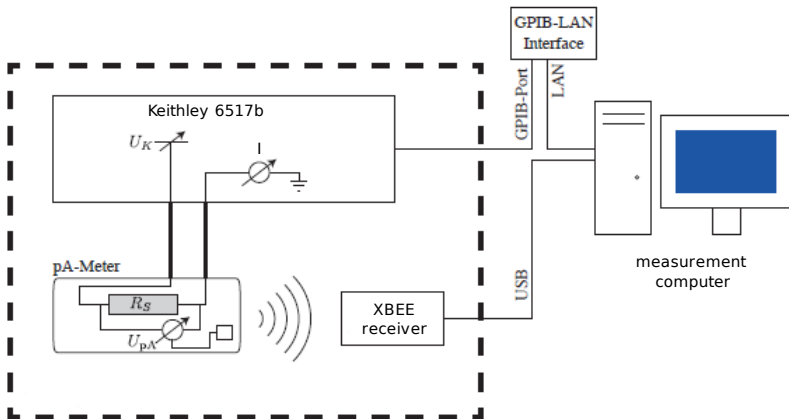
Firmware Workflow II



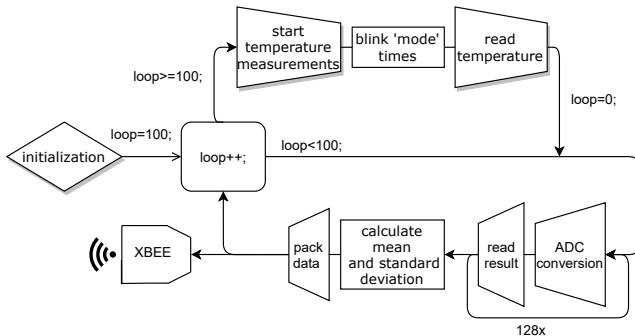
Parameter

DestAddress	Address of the receiver station
dataFormat	Select between ADC raw values or their mean
delay	Adds a delay to adjust the readout rate

Calibration Setup



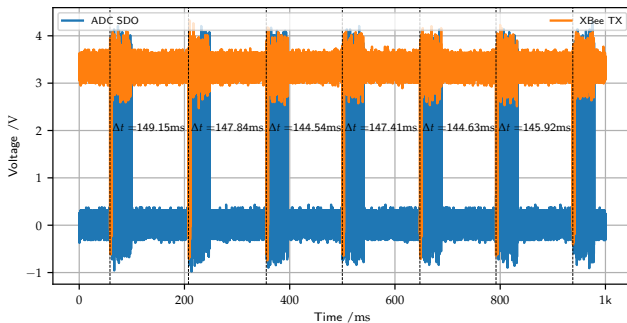
Firmware Workflow New

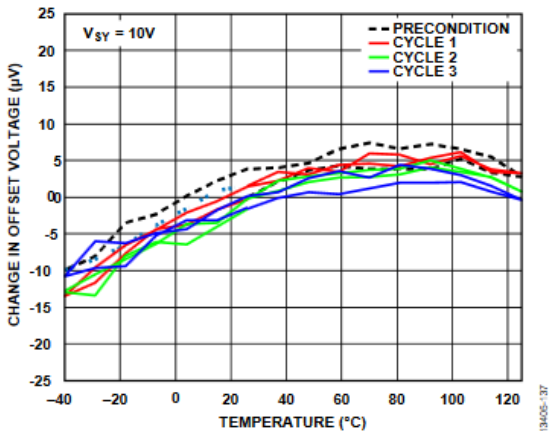


Temperature

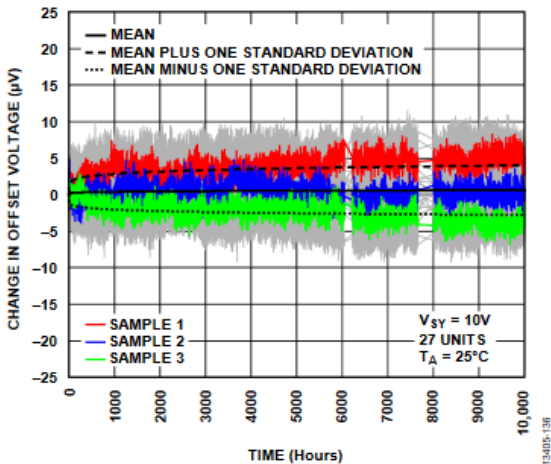
Component	Parameter	Fluctuation in the range of 15 to 30 °C
ADA4530 [1]	Offset voltage	$\pm 5 \mu\text{V}$
	Input bias current	$\pm 0.1 \text{ fA}$
LTC2327 [2]	Non-Linearity	$\leq 1 \text{ LSB}$
	Full-Scale Error	$\pm 2 \text{ LSB}$
	Offset Error	$\ll 1 \text{ LSB}$
Feedback resistor	Temperature Drift	0.3 %

Prototype Duty-cycle





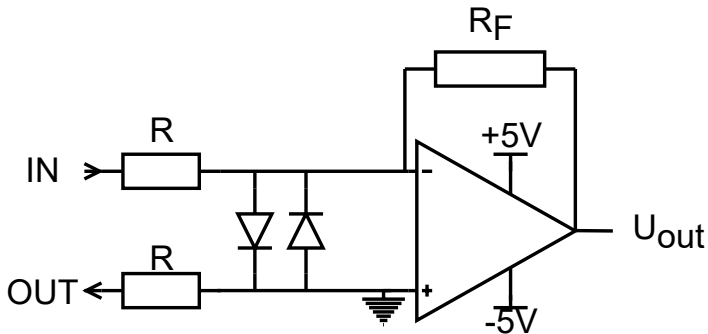
ADA4530 II



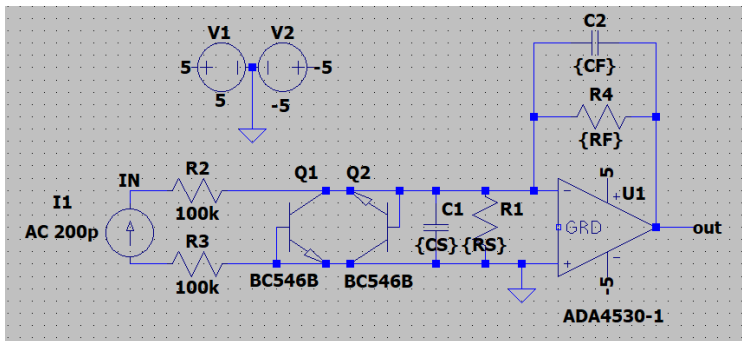
Cleaning

1. Ultrasonic cleaning in isopropyl alcohol for 30 min
2. flushing the board with isopropyl
3. use a brush scrub the solder joints
4. blow dry using compressed air
5. solder relays in place
6. repeat step 2, 3 & 4
7. bake the board at 80 °C for 3 h

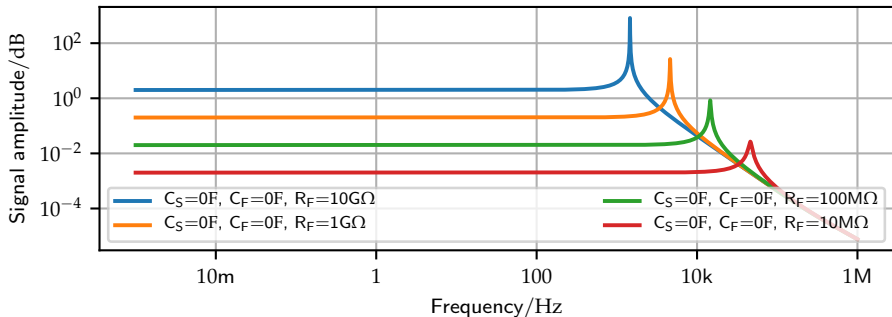
TIA OVP



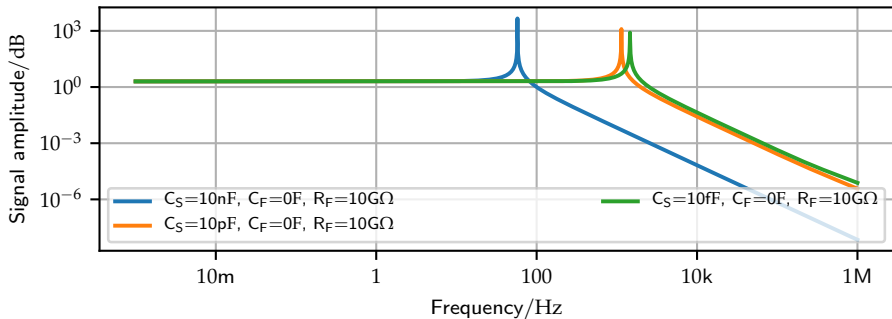
TIA Model



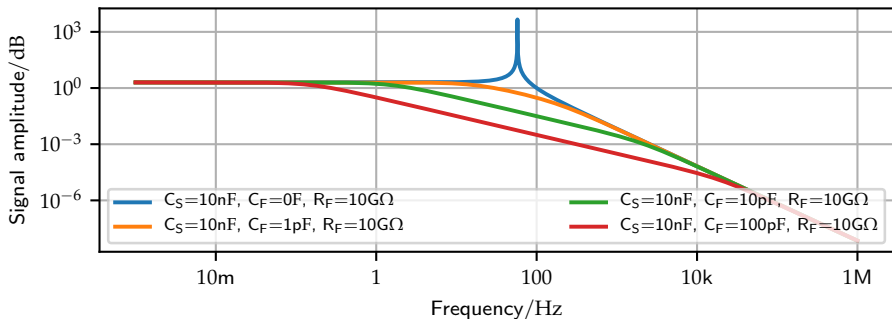
AC Simulation



AC Simulation

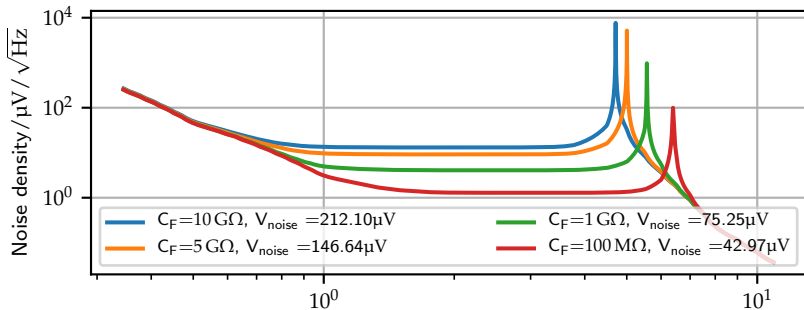


AC Simulation



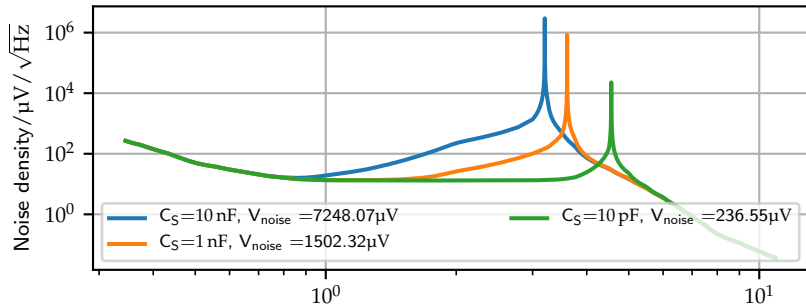
Noise Simulation

$C_S=0\text{ F}, C_F=0\text{ F}$



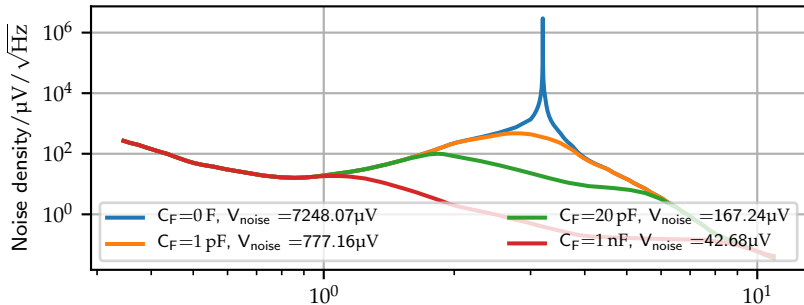
Noise Simulation

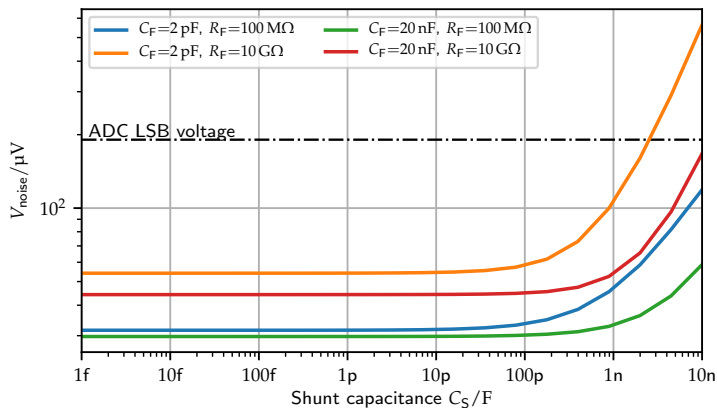
$C_F=0\text{ F}$, $R_F=10\text{ G}\Omega$



Noise Simulation

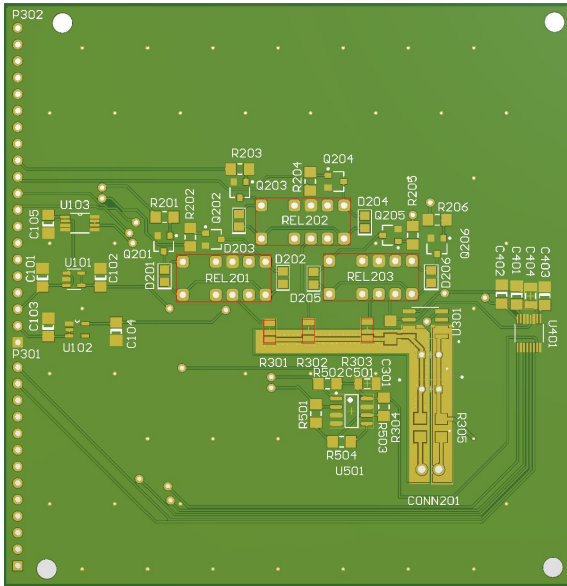
$R_F = 10 \text{ G}\Omega$, $C_S = 10 \text{ nF}$







Prototype Front-End



Bibliography



ADA4530 - Femtoampere Input Bias Current Electrometer Amplifier, b edition, 2017.



LTC2327-16 datasheet, b edition, 2017.